

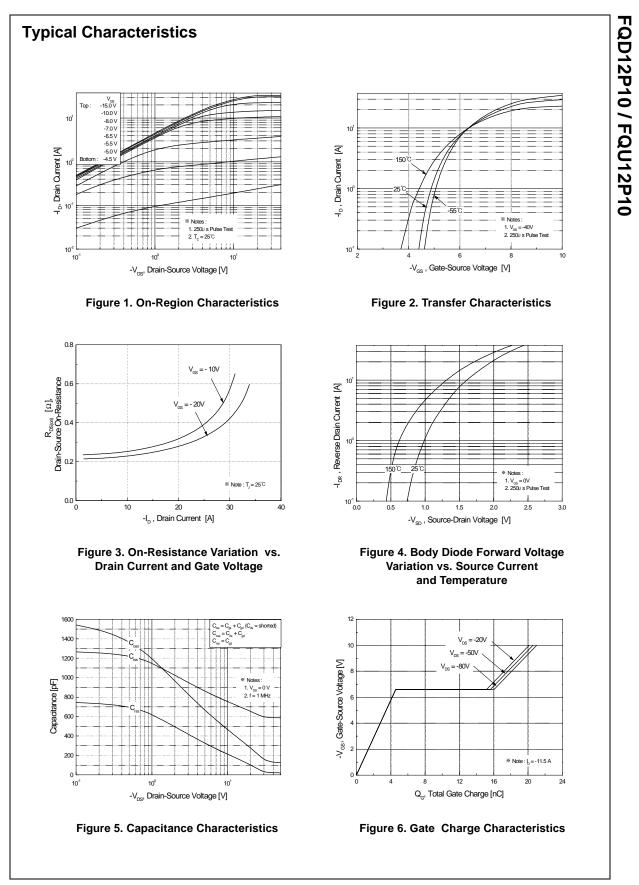
## Absolute Maximum Ratings T<sub>C</sub> = 25°C unless otherwise noted

Symbol	Parameter		FQD12P10 / FQU12P10	Units
V <sub>DSS</sub>	Drain-Source Voltage		-100	V
I <sub>D</sub>	Drain Current - Continuous (T <sub>C</sub> = 25°C)		-9.4	А
	- Continuous (T <sub>C</sub> = 100°C)		-6.0	А
I <sub>DM</sub>	Drain Current - Pulsed	(Note 1)	-37.6	А
V <sub>GSS</sub>	Gate-Source Voltage		± 30	V
E <sub>AS</sub>	Single Pulsed Avalanche Energy (Note 2)		370	mJ
I <sub>AR</sub>	Avalanche Current	(Note 1)	-9.4	А
E <sub>AR</sub>	Repetitive Avalanche Energy (Note		5.0	mJ
dv/dt	Peak Diode Recovery dv/dt (Note 3)		-6.0	V/ns
P <sub>D</sub>	Power Dissipation ( $T_A = 25^{\circ}C$ ) *		2.5	W
	Power Dissipation ( $T_C = 25^{\circ}C$ )		50	W
	- Derate above 25°C		0.4	W/°C
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Temperature Range		-55 to +150	°C
TL	Maximum lead temperature for soldering purposes, 1/8" from case for 5 seconds		300	°C

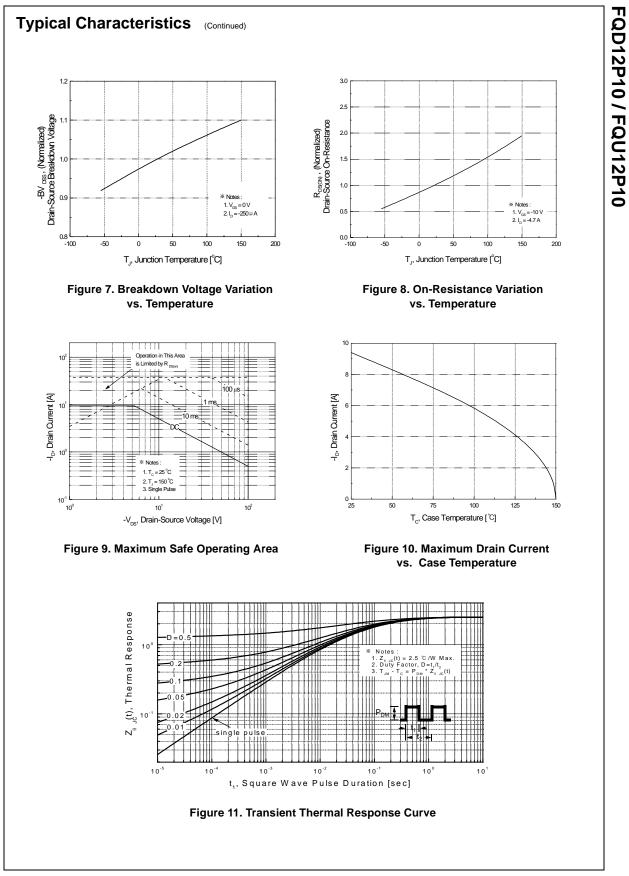
# **Thermal Characteristics**

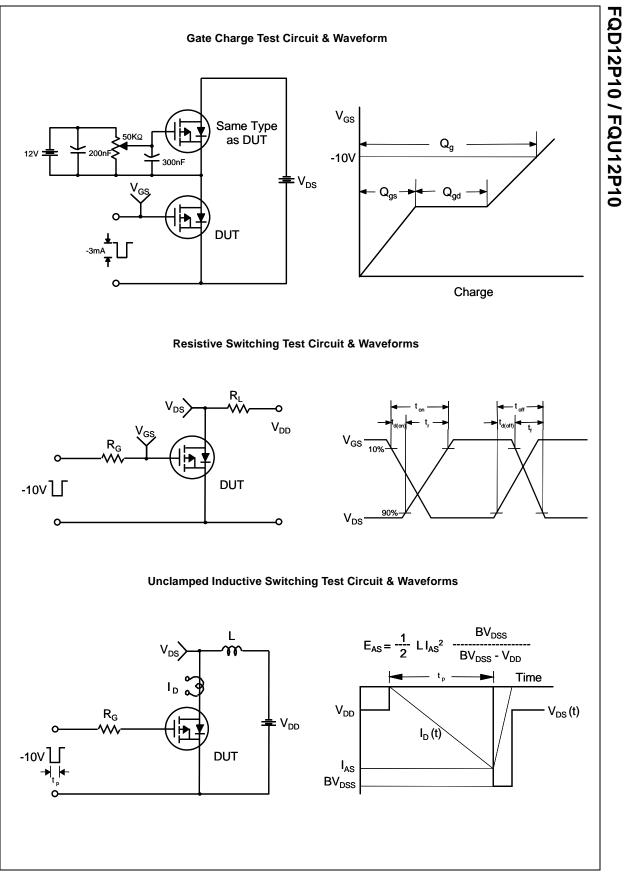
Symbol	Parameter	Тур	Max	Units
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case		2.5	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient *		50	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient		110	°C/W

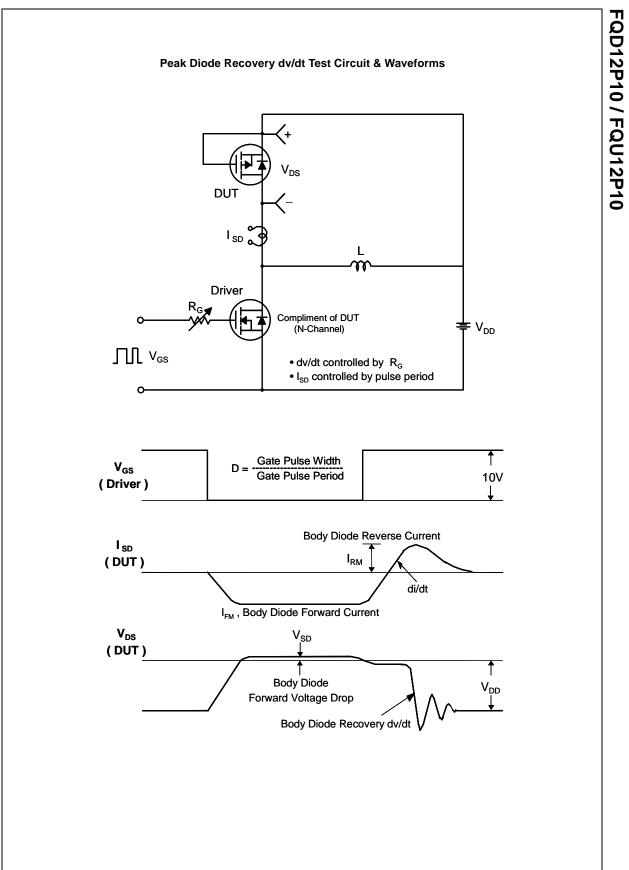
BV <sub>DSS</sub> ΔBV <sub>DSS</sub> ′ΔT <sub>J</sub>	racteristics		Min	Тур	Max	Units
BV <sub>DSS</sub> ΔBV <sub>DSS</sub> ΔΔT <sub>J</sub>						
ABV <sub>DSS</sub>	Drain-Source Breakdown Voltage	V <sub>GS</sub> = 0 V, I <sub>D</sub> = -250 μA	-100			V
DSS	Breakdown Voltage Temperature Coefficient	$I_D = -250 \ \mu\text{A}$ , Referenced to 25°C		-0.1		V/°C
	Zara Gata Valtaga Drain Current	V <sub>DS</sub> = -100 V, V <sub>GS</sub> = 0 V			-1	μA
	Zero Gate Voltage Drain Current	$V_{DS} = -80 \text{ V}, \text{ T}_{C} = 125^{\circ}\text{C}$			-10	μA
GSSF	Gate-Body Leakage Current, Forward	$V_{GS} = -30 \text{ V}, \text{ V}_{DS} = 0 \text{ V}$			-100	nA
GSSR	Gate-Body Leakage Current, Reverse	$V_{GS} = 30 \text{ V}, V_{DS} = 0 \text{ V}$			100	nA
On Cha	racteristics					
V <sub>GS(th)</sub>	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = -250 \mu A$	-2.0		-4.0	V
R <sub>DS(on)</sub>	Static Drain-Source On-Resistance	V <sub>GS</sub> = -10 V, I <sub>D</sub> = -4.7 A		0.24	0.29	Ω
ĴFS	Forward Transconductance	$V_{DS} = -40 \text{ V}, I_D = -4.7 \text{ A}$ (Note 4)		6.3		S
Dynamı C <sub>iss</sub>	c Characteristics	$V_{DS} = -25 V_{c} V_{cS} = 0 V_{c}$		620	800	pF
2 <sub>iss</sub>	Input Capacitance	V <sub>DS</sub> = -25 V, V <sub>GS</sub> = 0 V,		620	800	pF
	Output Capacitance	f = 1.0 MHz		220	290	pF
Srss	Reverse Transfer Capacitance			65	85	pF
C <sub>oss</sub> C <sub>rss</sub> Switchi	Reverse Transfer Capacitance ng Characteristics			65	85	pF
Switchi	·	Vpp = -50 V. lp = -11.5 A.		65 15	85 40	pF ns
Crss Switchi d(on)	ng Characteristics	V <sub>DD</sub> = -50 V, I <sub>D</sub> = -11.5 A, R <sub>G</sub> = 25 Ω			[	
C <sub>rss</sub> Switchi d(on) r	ng Characteristics Turn-On Delay Time	$R_{G} = 25 \Omega$		15	40	ns
C <sub>rss</sub> Switchi d(on) r d(off)	ng Characteristics Turn-On Delay Time Turn-On Rise Time			15 160	40 330	ns
S <sub>rss</sub>	ng Characteristics Turn-On Delay Time Turn-On Rise Time Turn-Off Delay Time	$R_{G} = 25 \Omega$		15 160 35	40 330 80	ns ns ns
C <sub>rss</sub> <b>Switchi</b> d(on) r d(off) f Q <sub>g</sub>	ng Characteristics Turn-On Delay Time Turn-On Rise Time Turn-Off Delay Time Turn-Off Fall Time	R <sub>G</sub> = 25 Ω (Note 4, 5)	  	15 160 35 60	40 330 80 130	ns ns ns ns
C <sub>rss</sub> Switchi d(on) r d(off) f	ng Characteristics Turn-On Delay Time Turn-On Rise Time Turn-Off Delay Time Turn-Off Fall Time Total Gate Charge	$R_G = 25 $ Ω (Note 4, 5) $V_{DS} = -80 $ V, $I_D = -11.5$ A,	   	15 160 35 60 21	40 330 80 130 27	ns ns ns ns nC
$\hat{c}_{rss}$ <b>Switchi</b> d(on) r d(off) f $\hat{c}_{g}$ $\hat{c}_{gs}$ $\hat{c}_{gd}$	ng Characteristics Turn-On Delay Time Turn-On Rise Time Turn-Off Delay Time Turn-Off Fall Time Total Gate Charge Gate-Source Charge	$R_{G} = 25 \ \Omega$ (Note 4, 5) $V_{DS} = -80 \ V, \ I_{D} = -11.5 \ A,$ $V_{GS} = -10 \ V$ (Note 4, 5)	    	15 160 35 60 21 4.6	40 330 80 130 27 	ns ns ns nC nC
Crss Switchi d(on) r d(off) f Δg Δg Δgg Δgg Δgg Drain-S	ng Characteristics Turn-On Delay Time Turn-On Rise Time Turn-Off Delay Time Turn-Off Fall Time Total Gate Charge Gate-Source Charge Gate-Drain Charge	$R_{G} = 25 \ \Omega$ (Note 4, 5) $V_{DS} = -80 \ V, I_{D} = -11.5 \ A,$ $V_{GS} = -10 \ V$ (Note 4, 5) Note 4, 5)	    	15 160 35 60 21 4.6	40 330 80 130 27 	ns ns ns nC nC
$\sum_{rss}$ Switchi d(on) r d(off) f $\lambda_g$ $\lambda_{gs}$ $\lambda_{gd}$ Drain-S s	ng Characteristics Turn-On Delay Time Turn-On Rise Time Turn-Off Delay Time Turn-Off Fall Time Total Gate Charge Gate-Source Charge Gate-Drain Charge ource Diode Characteristics ar	$R_{G} = 25 \Omega$ (Note 4, 5) $V_{DS} = -80 V, I_{D} = -11.5 A,$ $V_{GS} = -10 V$ (Note 4, 5) (Note 4, 5	     	15 160 35 60 21 4.6	40 330 80 130 27  	ns ns ns nC nC
Crss Switchi d(on) r d(off) f Ωg Ωgs Ωgg Ωrain-S s SM	ng Characteristics Turn-On Delay Time Turn-On Rise Time Turn-Off Delay Time Turn-Off Fall Time Total Gate Charge Gate-Source Charge Gate-Drain Charge ource Diode Characteristics an Maximum Continuous Drain-Source Diode	$R_{G} = 25 \Omega$ (Note 4, 5) $V_{DS} = -80 V, I_{D} = -11.5 A,$ $V_{GS} = -10 V$ (Note 4, 5) (Note 4, 5	      	15 160 35 60 21 4.6 11.5	40 330 80 130 27   	ns ns ns nC nC nC
$\sum_{rss}$ <b>Switchi</b> d(on) r d(off) f $2_{g}$ $2_{gs}$ $2_{gd}$	ng Characteristics Turn-On Delay Time Turn-On Rise Time Turn-Off Delay Time Turn-Off Fall Time Total Gate Charge Gate-Source Charge Gate-Drain Charge ource Diode Characteristics an Maximum Continuous Drain-Source Diode F	$R_{G} = 25 \ \Omega$ (Note 4, 5) $V_{DS} = -80 \ V, I_{D} = -11.5 \ A,$ $V_{GS} = -10 \ V$ (Note 4, 5) (N	     	15 160 35 60 21 4.6 11.5	40 330 80 130 27             	ns ns ns nC nC A A



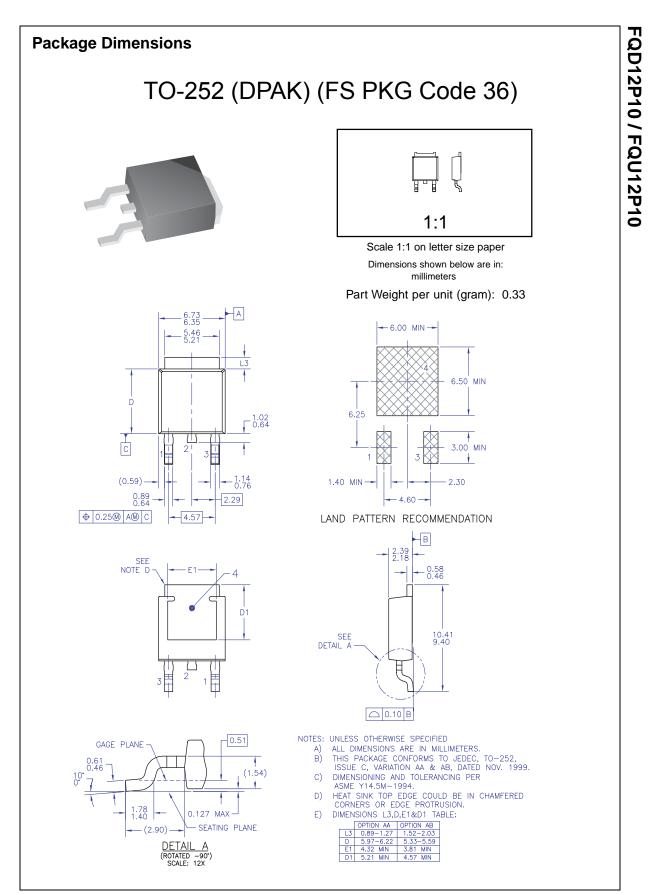
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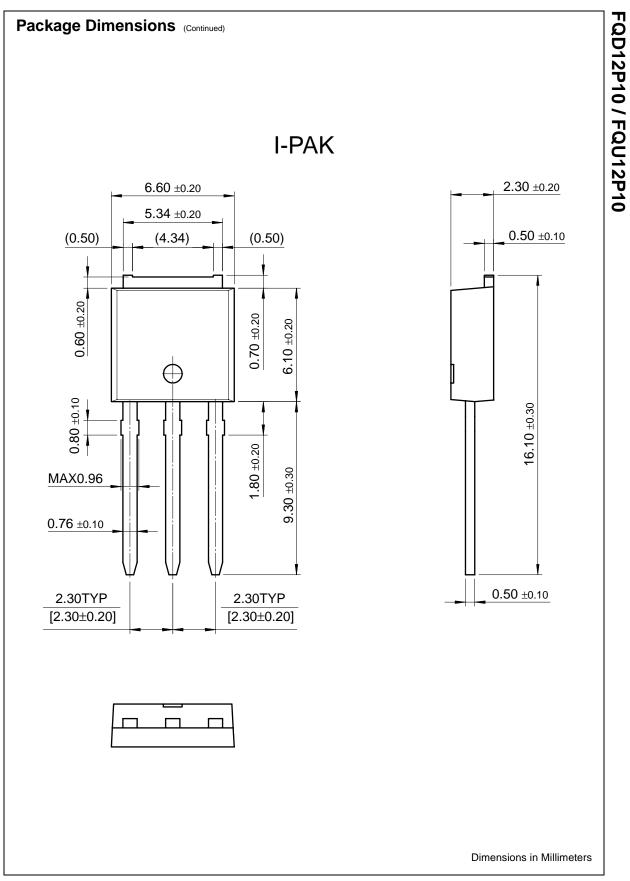




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